

Notice of References Cited		Application/Control No. 10/700,338	Applicant(s)/Patent Under Reexamination CIRNE ET AL.	
		Examiner ZHENG WEI	Art Unit 2192	Page 1 of 1

U.S. PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A US-6,738,965	05-2004	Webster, Matthew Alexander	717/128
*	B US-6,139,198	10-2000	Danforth et al.	717/128
*	C US-2002/0199172	12-2002	Bunnell, Mitchell	717/128
*	D US-2002/0066081	05-2002	Duesterwald et al.	717/128
*	E US-5,896,536	04-1999	Lindsey, Anthony Hayden	717/128
F	US-			
G	US-			
H	US-			
I	US-			
J	US-			
K	US-			
L	US-			
M	US-			

FOREIGN PATENT DOCUMENTS

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P					
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NON-PATENT DOCUMENTS

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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V	
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